

## *Amendments to the Specification*

Please replace the paragraph at page 28, second full paragraph, with the following:

**[00089]** The envelope of the intensity signal obtained from a phase grating 31, 32 extending in the x-direction provides the capture position of the phase mark 10 in the y-direction. In a similar manner, the capture position of a phase mark 10 extending in the y-direction will provide a capture position in the x-direction. When phase marks 10 are present on the wafer in both the x- and y-direction in a known configuration (i.e. with known mutual offsets 35, 36, see the example shown in figure 9 with two phase gratings 31, 32 extending in the x-direction and two phase gratings 33, 34 extending in the y-direction), the found capture positions in the x- and y-direction can be used as expected positions in a normal coarse alignment procedure (e.g. using a combination of 8.0  $\mu\text{m}$  and 8.8  $\mu\text{m}$  phase gratings as described above). Sometimes, it may still be desirable to perform a coarse alignment. For example, the accuracy of the diagonal scan procedure (the envelope signal), e.g. 30  $\mu\text{m}$  dependent on the width of the phase grating marks 10 used, may be sufficient to determine the correct top in a 88  $\mu\text{m}$  periodic signal (as delivered by the 8.0/8.8  $\mu\text{m}$  phase grating combination discussed above), but not sufficiently accurate to determine the correct top in a 8.0  $\mu\text{m}$  periodic signal.

At page 42, please replace paragraph [000129] with the following:

**[000129]** However, alternatively only a single intensity measurement may be used for each position along the scanning path 74, 76, which in this case runs perpendicular or under a non-zero angle to the direction of periodic variation. Thus, a an intensity measurement for the same phase may be obtained at each position along the scanning path 74, 76. As a result, the relative maximum among these measurements may still be characteristic for maximum amplitude. However, this approach may have a risk that an inconvenient phase is used. Therefore, it may be desirable to determine the maximum for at least two parallel scanning paths that are a quarter of a period (plus any number of full periods) apart, although it may also be possible to use any other distance unequal to an integer number of half periods.